DATA SHEET



SILICON POWER TRANSISTOR 2SA1649, 2SA1649-Z

PNP SILICON EPITAXIAL POWER TRANSISTOR FOR HIGH-SPEED SWITCHING

The 2SA1649 is a mold power transistor developed for highspeed switching and features a very low collector-to-emitter saturation voltage.

This transistor is ideal for use in switching regulators, DC/DC converters, motor drivers, solenoid drivers, and other low-voltage power supply devices, as well as for high-current switching.

FEATURES

- · Available for high-current control in small dimension
- Z type is a lead processed product and is deal for mounting a hybrid IC.
- Mold package that does not require an insulating board or insulation bushing
- Low collector saturation voltage: V_{CE(sat)} = -0.3 V MAX. (@Ic = -3 A)
- Fast switching speed:
 tf = 0.3 μs MAX. (@Ic = -3 A)
- · High DC current amplifiers and excellent linearity

ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

Parameter	Symbol	Ratings	Unit
Collector to base voltage	Vсво	-40	V
Collector to emitter voltage	Vceo	-30	V
Emitter to base voltage	Vebo	-7.0	V
Collector current (DC)	IC(DC)	-10	А
Collector current (pulse)	C(pulse)*	-20	А
Base current (DC)	IB(DC)	-3.5	А
Total power dissipation	P⊤ (Tc = 25 °C)	15	W
Total power dissipation	P⊤ (Ta = 25 °C)	1.0**, 2.0***	W
Junction temperature	Tj	150	°C
Storage temperature	Tstg	-55 to +150	°C

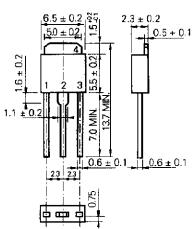
- *: PW \leq 300 μ s, duty cycle \leq 10%
- **: Printing board mounted

***: 7.5 $\text{mm}^2 \times 0.7$ mm ceramic board mounted

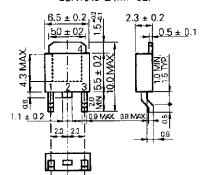
The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

PACKAGE DRAWING (UNIT: mm)

2SA1649 (MP-3)



2SA1649-Z (MP-3Z)



Electrode Connection

1. Base 2. Collector

3. Emitter

4. Fin (collector)

ELECTRICA64 CHARACTERISTICS (Ta = 25°C)

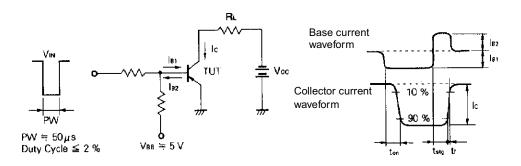
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector to emitter voltage	VCEO(SUS)	Ic = -4.0 A, I _B = -0.4 A, L = 1 mH	-30			V
Collector to emitter voltage	VCEX(SUS)	Ic = -4.0 A, I _{B2} = -I _{B1} = -0.4 A, V _{BE(OFF)} = 1.5 V, L = 180 μ H, clamped	-40			V
Collector cutoff current	Ісво	$V_{CE} = -30 \text{ V}, \text{ IE} = 0$			-10	μA
Collector cutoff current	ICER	$V_{CE} = -30 \text{ V}, \text{ R}_{BE} = 50 \Omega, \text{ Ta} = 125^{\circ}\text{C}$			-1.0	mA
Collector cutoff current	ICEX1	Vce = -30 V, VBE(OFF) = 1.5 V			-10	μA
Collector cutoff current	ICEX2	$V_{CE} = -30 \text{ V}, \text{ V}_{BE(OFF)} = 1.5 \text{ V},$ Ta = 125°C			-1.0	mA
Emitter cutoff current	Іево	V _{EB} = -5.0 V, Ic = 0			-10	μA
DC current gain	hfe1*	Vce = -2.0 V, Ic = -0.5 A	100			-
DC current gain	hfe2*	Vce = -2.0 V, Ic = -2.0 A	100	200	400	-
DC current gain	hfe3*	Vce = -2.0 V, Ic = -4.0 A	60			-
Collector saturation voltage	V _{CE(sat)1} *	Ic = −3.0 A, I _B = −0.2 A			-0.3	V
Collector saturation voltage	VCE(sat)2*	Ic = -4.0 A, I _B = -0.3 A			-0.5	V
Base saturation voltage	VBE(sat)1*	Ic = −3.0 A, I _B = −0.2 A			-1.2	V
Base saturation voltage	VBE(sat)2*	Ic = −4.0 A, I _B = −0.3 A			-1.5	V
Collector capacitance	Cob	$V_{CB} = -10 V$, $I_E = 0$, $f = 1.0 MHz$		250		pF
Gain bandwidth product	f⊤	$V_{CE} = -10 \text{ V}, \text{ Ic} = -0.5 \text{ A}$		120		MHz
Turn-on time	ton	Ic = -4.0 A, R _L = 5 Ω,			0.3	μs
Storage time	tstg	$I_{B1} = -I_{B2} = -0.15 \text{ A}, \text{ Vcc} \cong -20 \text{ V}$ Refer to the test circuit.			1.5	μs
Fall time	tr				0.3	μs

* Pulse test PW \leq 350 μ s, duty cycle \leq 2%/pulsed

hfe CLASSIFICATION

Marking	М	L	к
hfe2	100 to 200	150 to 300	200 to 400

SWITCHING TIME (ton, tstg, tf) TEST CIRCUIT



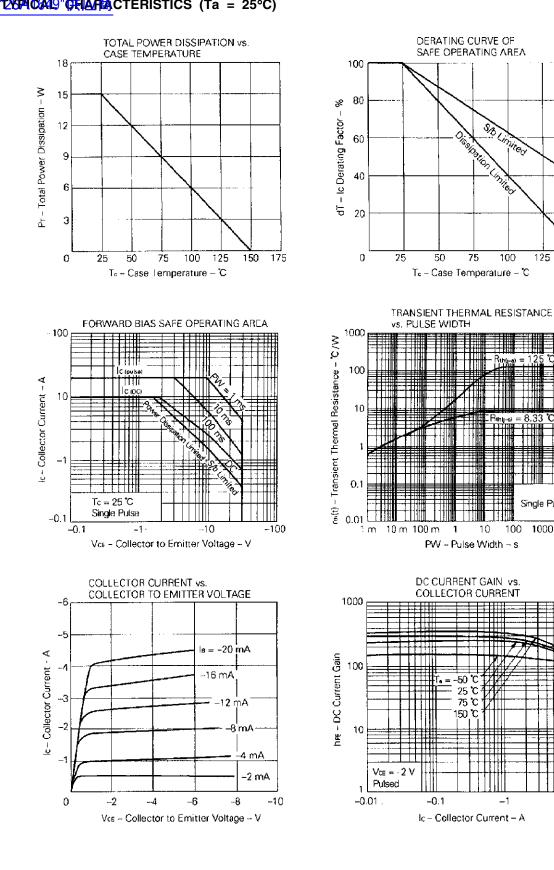
150

125

Single Pulse

1000 10000

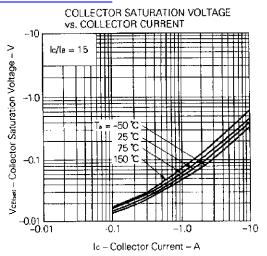
-10

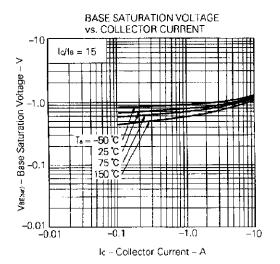


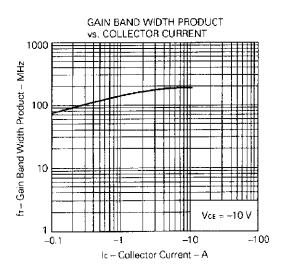
查询"260402419"(供应FAISTICS (Ta = 25°C)

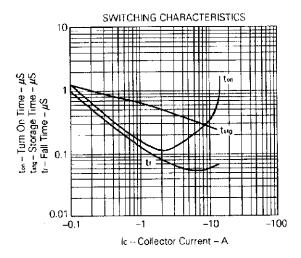
查询"2SA1649"供应商

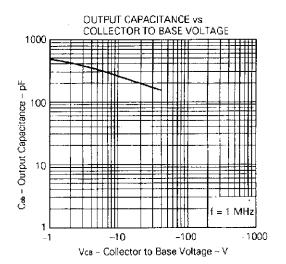
NEC

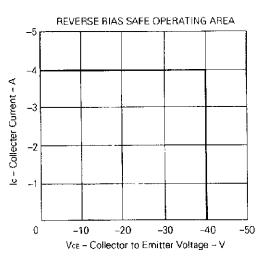












查询[[MEM049"供应商

查询"2SA1649"供应商

- The information in this document is current as of July, 2001. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC's data sheets or data books, etc., for the most up-to-date specifications of NEC semiconductor products. Not all products and/or types are available in every country. Please check with an NEC sales representative for availability and additional information.
- No part of this document may be copied or reproduced in any form or by any means without prior written consent of NEC. NEC assumes no responsibility for any errors that may appear in this document.
- NEC does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from the use of NEC semiconductor products listed in this document or any other liability arising from the use of such products. No license, express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software and information in the design of customer's equipment shall be done under the full responsibility of customer. NEC assumes no responsibility for any losses incurred by customers or third parties arising from the use of these circuits, software and information.
- While NEC endeavours to enhance the quality, reliability and safety of NEC semiconductor products, customers
 agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. To minimize
 risks of damage to property or injury (including death) to persons arising from defects in NEC
 semiconductor products, customers must incorporate sufficient safety measures in their design, such as
 redundancy, fire-containment, and anti-failure features.
- NEC semiconductor products are classified into the following three quality grades:

"Standard", "Special" and "Specific". The "Specific" quality grade applies only to semiconductor products developed based on a customer-designated "quality assurance program" for a specific application. The recommended applications of a semiconductor product depend on its quality grade, as indicated below. Customers must check the quality grade of each semiconductor product before using it in a particular application.

- "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots
- "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
- "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC semiconductor products is "Standard" unless otherwise expressly specified in NEC's data sheets or data books, etc. If customers wish to use NEC semiconductor products in applications not intended by NEC, they must contact an NEC sales representative in advance to determine NEC's willingness to support a given application.

(Note)

(1) "NEC" as used in this statement means NEC Corporation and also includes its majority-owned subsidiaries.

(2) "NEC semiconductor products" means any semiconductor product developed or manufactured by or for NEC (as defined above).